IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Fay - Ching Urien.

Shean-Jen CHEN, Chun-Yu LIN, Fan-Ching CHIEN, K. T. HUANG, W. P. HU,

Applicant(s) : Wen-Yih CHEN, Kuan-Ching LEE and Wen-Hsien LI

Date

Serial No. Group Art Unit:

Filed

For

: SURFACE PLASMON RESONANCE SENSOR WITH HIGH SENSITIVITY

Honorable Commissioner of Patents

and Trademarks

Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT

Sir:

Attached is a completed Form PTO-1449 and copies of the pertinent parts of the references cited thereon. Comments on any non-English-language references (if any) pursuant to Rule are submitted herewith.

Respectfully submitted

Kean-Ching Lee Wente

Chun-Yu Lin Four-Ching Chien

K.T. Muang Wen Pin Un Mastlern

Encl: PTO-1449 & References

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FORM PTO-1449 (Substitute) LIST OF PRIOR ART CITED BY APPLICANT (Use several sheets if necessary)				ATTY. DOCKET NO. 03/96-UPS	SERIAL NO.			
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			U.S. PA	TENT DOCUMENTS				
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APROPRIATE	
	AA	5,991,488	11/23/1999	Slamon et al.	385	129	11/7/1997	
. <u> </u>	AB	6,242,264	6/5/2001	Natan et al.	436	171	1/12/2000	
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